

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 106539		APPLICATION NO. 09/731,671	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANT(S) Michael NAHUM et al.			
				FILING DATE December 8, 2000		GROUP	


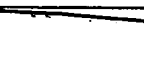


  

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
	4,794,384	12/88	JACKSON			
	4,967,093	10/90	TAKEMORI			
	4,671,650	06/87	HIRZEL et al.			
	5,453,840	09/95	PARKER et al.			


  

FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
	JP-56-26208 w/Eng. Abstract	03/81	JAPAN			
	JP-8-14,824 w/Eng. Abstract	01/96	JAPAN			
	JP-2-297,006 w/Eng. Abstract	12/90	JAPAN			
	JP-8-261,730 w/Eng. Abstract	10/96	JAPAN			
	JP-3-274,401 w/Eng. Abstract	12/91	JAPAN			
	JP-8-261,717 w/Eng. Abstract	10/96	JAPAN			
	JP-4-131,705 w/Eng. Abstract	05/92	JAPAN			
	JP-8-233,522 w/Eng. Abstract	09/96	JAPAN			
	JP-7-151,516 w/Eng. Abstract	06/95	JAPAN			
	JP-60-71911 w/Eng. Abstract	4/85	JAPAN			
	JP-8-271231 w/Eng. Abstract	10/96	JAPAN			
	JP-5-52517 w/Eng. Abstract	03/93	JAPAN			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)	
	YAMAGUCHI, Ichirou et al., "Linear and Rotary Encoders Using Electronic Speckle Correlation," <u>Optical Engineering</u> , Vol. 30, No. 12, 1991
	SUTTON, Michael A. et al., "Effects of Subpixel Image Restoration on Digital Correlation Error Estimates," <u>Optical Engineering</u> , Vol. 27, No. 10, 1988
	SJÖDAHL, M. "Accuracy in Electronic Speckle Photography," <u>Applied Optics</u> , Vol. 36, No. 13, 1997
	SCHRIJVER, Hubert et al. "Systematic Errors in Digital Image Correlation Caused by Intensity Interpolation," <u>Optical Engineering</u> , Vol. 39, No. 11, November 2000

EXAMINER 	DATE CONSIDERED 10/22/04
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Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.